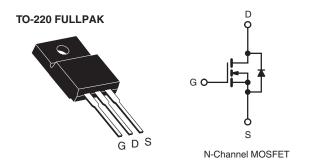


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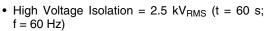
Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	100			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 5.0 V	0.16		
Q _g (Max.) (nC)	28			
Q _{gs} (nC)	3.8			
Q _{gd} (nC)	14			
Configuration	Single			



FEATURES

· Isolated Package





- Sink to Lead Creepage Dist. = 4.8 mm
- · Logic-Level Gate Drive
- R_{DS(on)} Specified at V_{GS} = 4 V and 5 V
- · Fast Switching
- · Ease of paralleling
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	FULLPAK220
Lead (Pb)-free	IRLI530GPbF
Lead (FD)-liee	SiHLI530G-E3
SnPb	IRLI530G
SILL	SiHLI530G

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	100	V	
Gate-Source Voltage			V_{GS}	± 10		
Continuous Drain Current	V _{GS} at 5.0 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$	I _D	9.7		
	VGS at 3.0 V	T _C = 100 °C		6.9	Α	
Pulsed Drain Current ^a			I _{DM}	39		
Linear Derating Factor				0.28	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	250	mJ	
Repetitive Avalanche Current ^a			I _{AR}	9.7	А	
Repetitive Avalanche Energy ^a			E _{AR}	4.2	mJ	
Maximum Power Dissipation	T _C = 25 °C		P_{D}	42	W	
Peak Diode Recovery dV/dt ^c			dV/dt	5.5	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	°C		
Soldering Recommendations (Peak Temperature)	for 10 s		·	300 ^d		
Mounting Torque	6 22 or N	6-32 or M3 screw		10	lbf ⋅ in	
	0-32 OF IVIS SCIEW			1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD}=25~V$, starting $T_J=25~^{\circ}C$, L=4.0~mH, $R_G=25~\Omega$, $I_{AS}=9.7~A$ (see fig. 12c).
- c. $I_{SD} \le 15$ A, $dI/dt \le 140$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 175$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRLI530G, SiHLI530G

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.6	C/VV	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							•
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	100	-	-	٧	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	0.14	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \mu A$		1.0	-	2.0	٧
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 10 V		-	-	± 100	nA
Zoro Coto Voltago Drain Current	1	V _{DS} = 100 V, V _{GS} = 0 V		-	-	25	^
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 80 V,	V _{GS} = 0 V, T _J = 150 °C	-	-	250	μA
Durin Occurs October 5	-	V _{GS} = 5.0 V	I _D = 5.8 A ^b	-	-	0.16	Ω
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 4.0 V	$I_D = 4.9 A^b$	-	-	0.22	
Forward Transconductance	9 _{fs}	V _{DS} =	25 V, I _D = 5.8 A ^b	6.1	-	-	S
Dynamic							
Input Capacitance	C _{iss}		V _{GS} = 0 V,		930	-	pF
Output Capacitance	C _{oss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz}, \text{ see fig. 5}$		-	250	-	
Reverse Transfer Capacitance	C _{rss}			-	57	-	
Drain to Sink Capacitance	С		f = 1 MHz	-	12	-	
Total Gate Charge	Qg			-	-	28	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 5.0 V	$V_{GS} = 5.0 \text{ V}$ $I_D = 15 \text{ A}, V_{DS} = 80 \text{ V},$ see fig. 6 and 13 ^b	-	-	3.8	
Gate-Drain Charge	Q_{gd}			-	-	14	
Turn-On Delay Time	t _{d(on)}	V_{DD} = 50 V, I_{D} = 15 A, R_{G} = 6.0 Ω , R_{D} = 32 Ω , see fig. 10 ^b		-	4.7	-	ns
Rise Time	t _r			-	100	-	
Turn-Off Delay Time	t _{d(off)}			-	22	-	
Fall Time	t _f			-	48	-	
Internal Drain Inductance	L_{D}	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	- nH
Internal Source Inductance	L _S			-	7.5	-	
Drain-Source Body Diode Characteristic	s			1		Į	
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	9.7	А
Pulsed Diode Forward Current ^a	I _{SM}			-	-	39	
Body Diode Voltage	V _{SD}	$T_J = 25 ^{\circ}\text{C}, \ I_S = 9.7 \text{A}, \ V_{GS} = 0 \text{V}^{\text{b}}$		-	-	2.5	V
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 {}^{\circ}\text{C}, \ I_F = 15 \text{A}, \ dI/dt = 100 \text{A}/\mu\text{s}^b$		-	100	200	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.70	1.4	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	n-on is don	ninated by	y L _S and I	_D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width $\leq 300~\mu s;$ duty cycle $\leq 2~\%.$



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

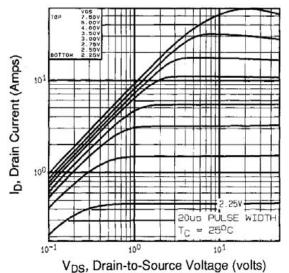


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

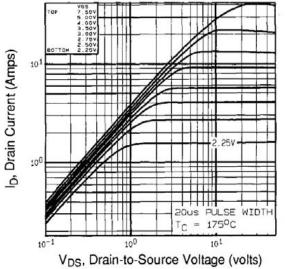


Fig. 2 - Typical Output Characteristics, $T_C = 175$ °C

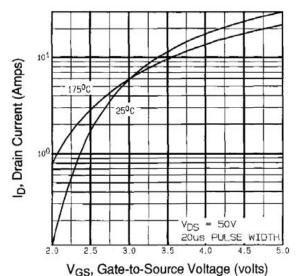


Fig. 3 - Typical Transfer Characteristics

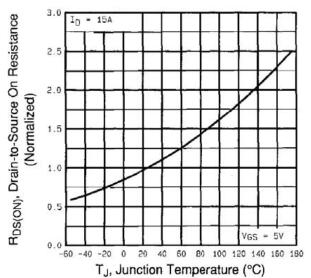


Fig. 4 - Normalized On-Resistance vs. Temperature

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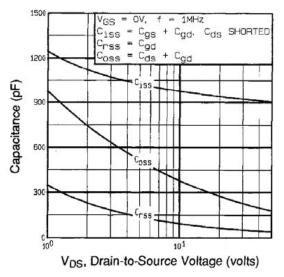


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

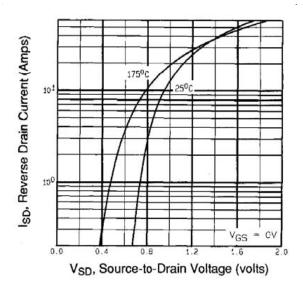


Fig. 7 - Typical Source-Drain Diode Forward Voltage

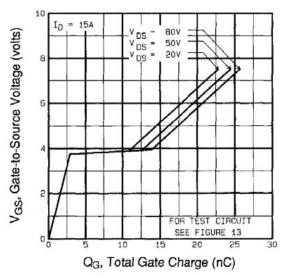


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

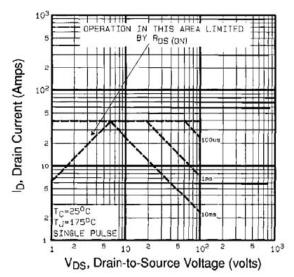
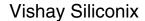


Fig. 8 - Maximum Safe Operating Area





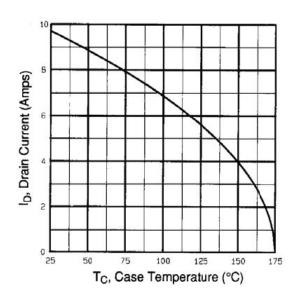


Fig. 9 - Maximum Drain Current vs. Case Temperature

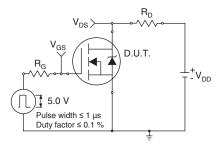


Fig. 10a - Switching Time Test Circuit

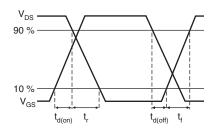


Fig. 10b - Switching Time Waveforms

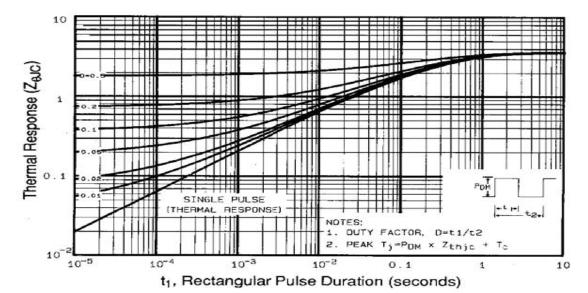


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

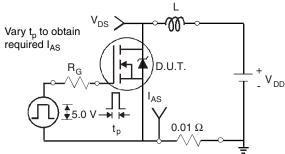


Fig. 12a - Unclamped Inductive Test Circuit

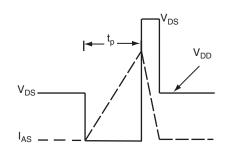


Fig. 12b - Unclamped Inductive Waveforms

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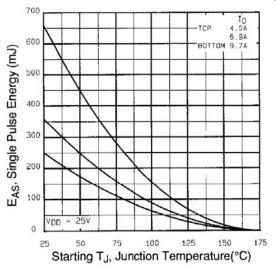


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

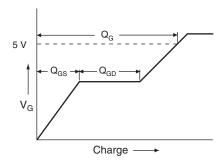


Fig. 13a - Basic Gate Charge Waveform

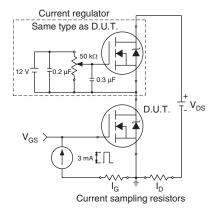
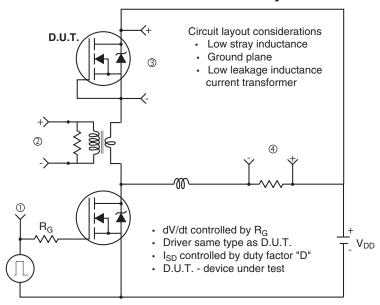
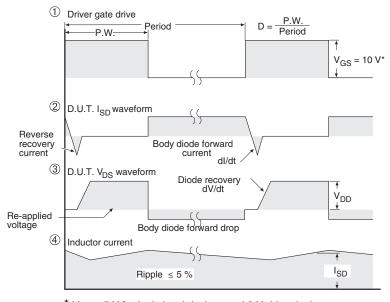


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





 * V_{GS} = 5 V for logic level devices and 3 V drive devices

Fig. 14 - For N-Channel

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